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NTNS3C94NZ

[MOSFET](#) – Single N-Channel, Small Signal, XLLGA3, 0.62 x 0.62 x 0.4 mm
12 V, 384 mA

ON Semiconductor®

Features

- Single N−Channel MOSFET
- Ultra Small and Thin Package (0.62 x 0.62 x 0.4 mm)
- Low $R_{DS(on)}$ Solution in 0.62 x 0.62 mm Package
- 1.8 V Gate Voltage Rating
- These Devices are Pb−Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Small Signal Load Switch
- Analog Switch
- High Speed Interfacing
- Optimized for Power Management in Ultra Portable Products

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Units
Drain-to-Source Voltage			V_{DSS}	12	V
Gate-to-Source Voltage			V_{GS}	±8	V
Continuous Drain Current (Note 1)	Steady State	T_A = 25°C	I_D	384	mA
		T_A = 85°C		277	
	$t \leq 5$ s	T_A = 25°C		413	
Power Dissipation (Note 1)	Steady State	T_A = 25°C	P_D	120	mW
	$t \leq 5$ s	T_A = 25°C		140	
Pulsed Drain Current	t_p = 10 μs		I_{DM}	115	A
Operating Junction and Storage Temperature			T_J, T_{STG}	-55 to 150	°C
Source Current (Body Diode) (Note 2)			I_S	157	mA
Lead Temperature for Soldering Purposes (1/8″ from case for 10 s)			T_L	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Units
Junction-to-Ambient − Steady State (Note 1)	$R_{\theta JA}$	1040	°C/W
Junction-to-Ambient − $t \leq 5$ s (Note 1)	$R_{\theta JA}$	900	

1. Surface Mounted on FR4 Board using the minimum recommended pad size, (or 2 mm^2), 1 oz Cu.
2. Pulse Test: pulse width $\leq$ 300 μs, duty cycle $\leq$ 2%.

MOSFET

$V_{(BR)DSS}$	$R_{DS(on)}$ MAX	I_D MAX
12 V	0.48 Ω @ 4.5 V	384 mA
	0.54 Ω @ 3.7 V	
	0.60 Ω @ 3.3 V	
	0.80 Ω @ 2.5 V	
	1.90 Ω @ 1.8 V	

N−Channel MOSFET

D (3)

G (1)

S (2)
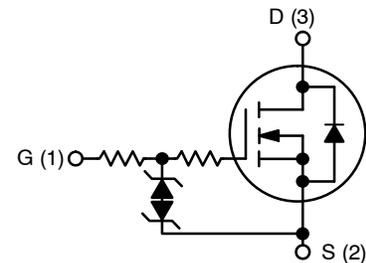
MARKING DIAGRAM

XLLGA3
CASE 713AE

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1 ○
  E M
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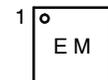
E = Specific Device Code
M = Date Code

ORDERING INFORMATION

Device	Package	Shipping[†]
NTNS3C94NZT5G	XLLGA3 (Pb−Free)	8000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

June, 2019− Rev. 1

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ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Typ	Max	Units
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	V_{GS} = 0 V, I_D = 250 μA		12			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$	I_D = 250 μA, ref to 25°C			11		mV/°C
Zero Gate Voltage Drain Current	I_{DSS}	V_{GS} = 0 V, V_{DS} = 9.6 V	T_J = 25°C			100	nA
Gate-to-Source Leakage Current	I_{GSS}	V_{DS} = 0 V, V_{GS} = ±10 V				±10	μA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	$V_{GS(TH)}$	V_{GS} = V_{DS}, I_D = 250 μA		0.4		1.0	V
Negative Gate Threshold Temperature Coefficient	$V_{GS(TH)}/T_J$				0.8		mV/°C
Drain-to-Source On Resistance	$R_{DS(on)}$	V_{GS} = 4.5 V, I_D = 100 mA			0.35	0.48	Ω
		V_{GS} = 3.7 V, I_D = 75 mA			0.40	0.54	
		V_{GS} = 3.3 V, I_D = 75 mA			0.43	0.60	
		V_{GS} = 2.5 V, I_D = 50 mA			0.55	0.80	
		V_{GS} = 1.8 V, I_D = 20 mA			1.0	1.9	
		V_{GS} = 1.5 V, I_D = 10 mA			1.8		
Forward Transconductance	g_{FS}	V_{DS} = 5 V, I_D = 100 mA			0.6		S
Source–Drain Diode Voltage	V_{SD}	V_{GS} = 0 V, I_S = 100 mA			0.76	1.0	V
CHARGES & CAPACITANCES							
Input Capacitance	C_{ISS}	V_{GS} = 0 V, f = 1 MHz, V_{DS} = 9. 6 V			35		pF
Output Capacitance	C_{OSS}				6.0		
Reverse Transfer Capacitance	C_{RSS}				4.1		
Total Gate Charge	$Q_{G(TOT)}$	V_{GS} = 4.5 V, V_{DS} = 9.6 V, I_D = 100 mA			0.6		nC
Threshold Gate Charge	$Q_{G(TH)}$				0.1		
Gate–to–Source Charge	Q_{GS}				0.1		
Gate–to–Drain Charge	Q_{GD}				0.1		
SWITCHING CHARACTERISTICS, VGS = 4.5 V (Note 3)							
Turn-On Delay Time	$t_{d(ON)}$	V_{GS} = 4.5 V, V_{DD} = 9.6 V, I_D = 100 mA, R_G = 2 Ω			7.0		ns
Rise Time	t_r				6.3		
Turn-Off Delay Time	$t_{d(OFF)}$				152		
Fall Time	t_f				80		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
3. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS
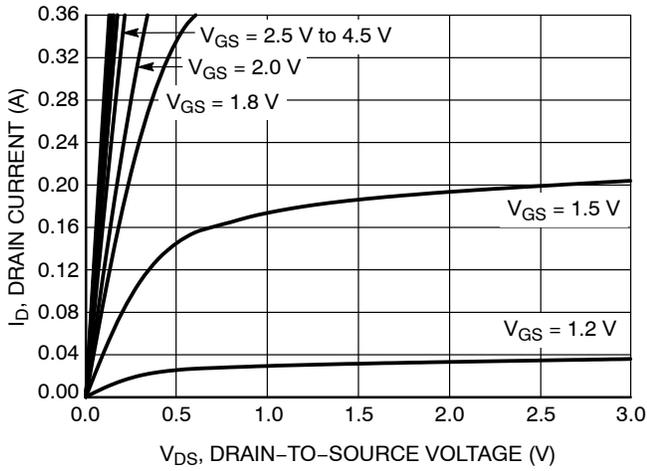
Figure 1. On−Region Characteristics
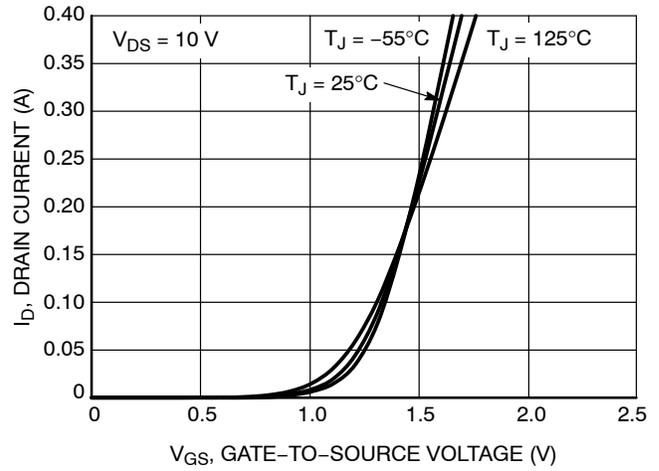
Figure 2. Transfer Characteristics
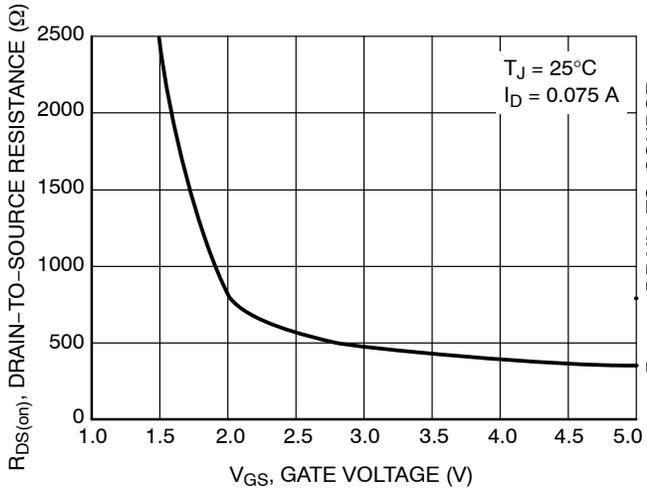
Figure 3. On−Resistance vs. Gate−to−Source Voltage
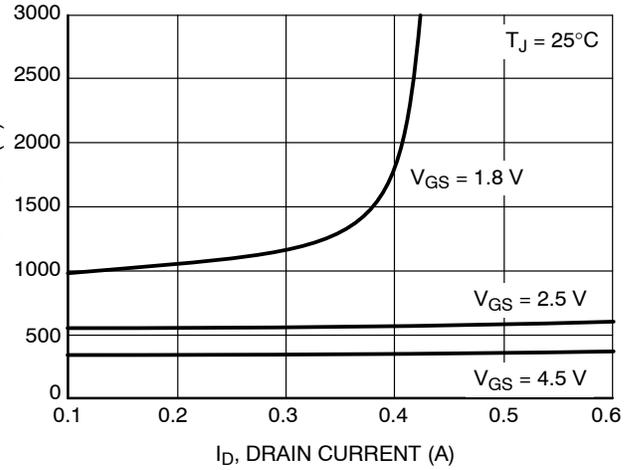
Figure 4. On−Resistance vs. Drain Current and Gate Voltage
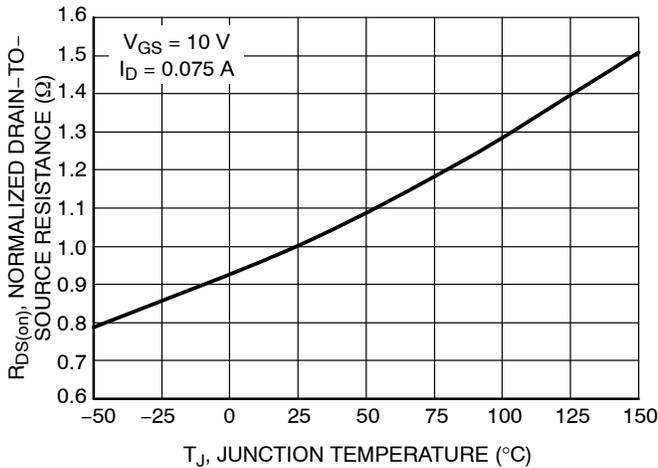
Figure 5. On−Resistance Variation with Temperature
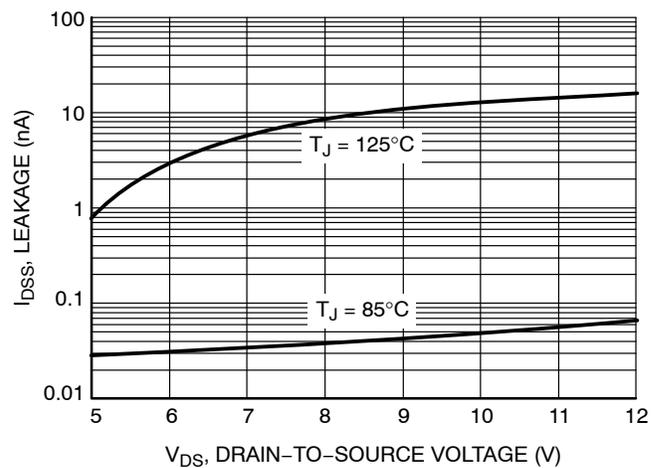
Figure 6. Drain−to−Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS
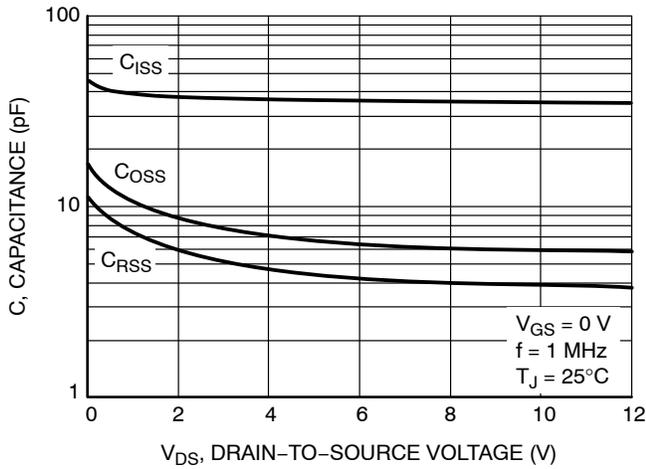
Figure 7. Capacitance Variation
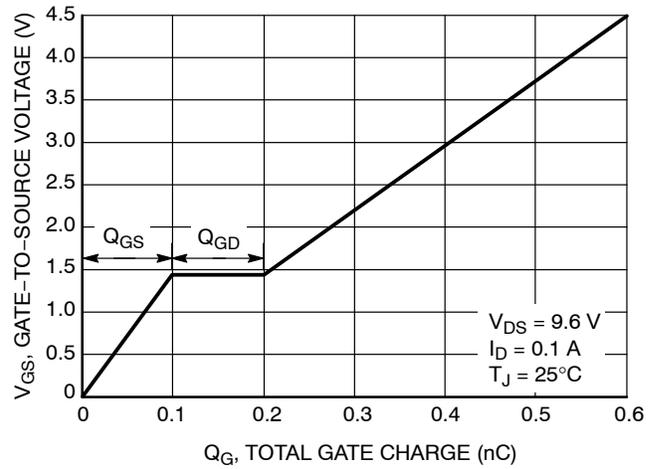
Figure 8. Gate−to−Source and Drain−to−Source Voltage vs. Total Charge
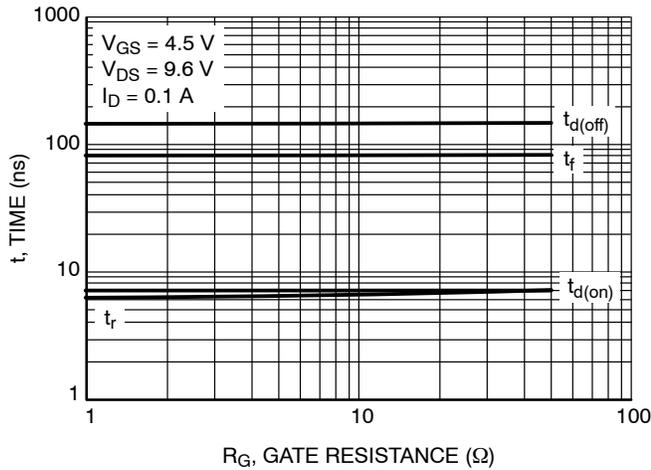
Figure 9. Resistive Switching Time Variation vs. Gate Resistance
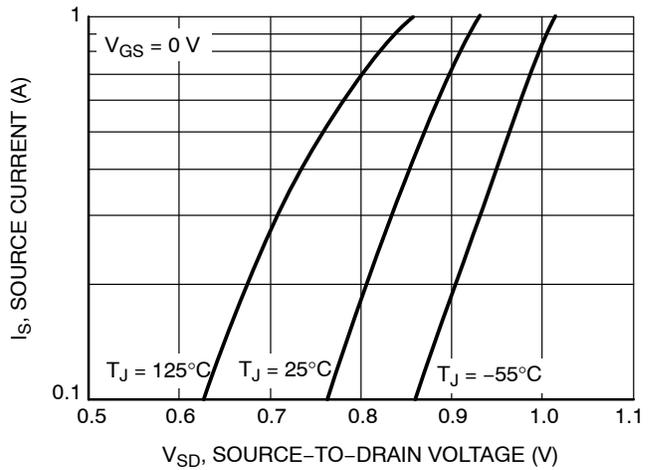
Figure 10. Diode Forward Voltage vs. Current
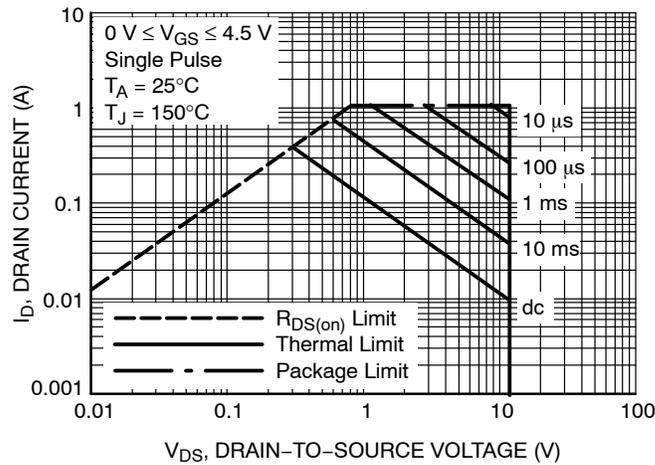
Figure 11. Maximum Rated Forward Biased Safe Operating Area

TYPICAL CHARACTERISTICS
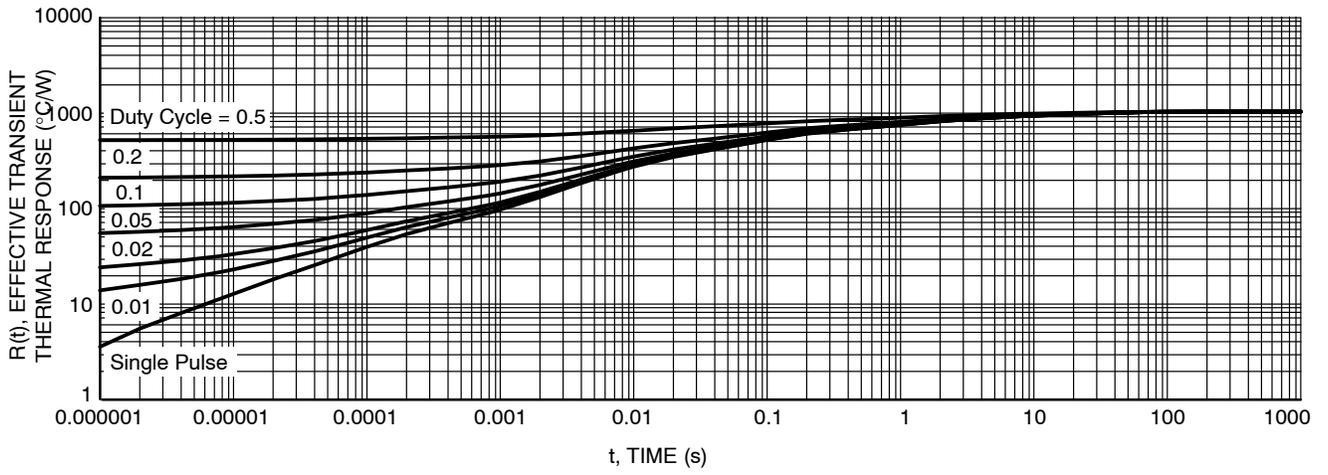
Figure 12. FET Thermal Response

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PACKAGE DIMENSIONS

XLLGA3, 0.62x0.62
CASE 713AE
ISSUE O

TOP VIEW

SIDE VIEW

BOTTOM VIEW
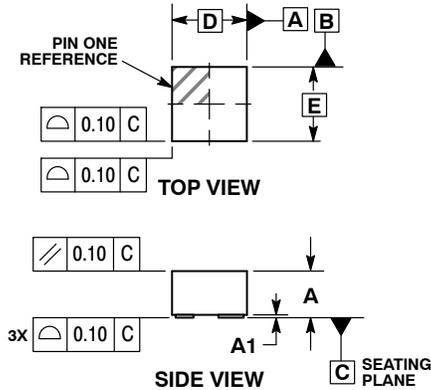
NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.

DIM	MILLIMETERS	
	MIN	MAX
A	0.340	0.440
A1	0.000	0.030
b	0.100	0.200
b1	0.150	0.250
D	0.620 BSC	
D2	0.175 BSC	
D3	0.205 BSC	
E	0.620 BSC	
E2	0.400	0.600
e	0.200 BSC	
e1	0.175 BSC	
L	0.090	0.210
L2	0.110	0.310
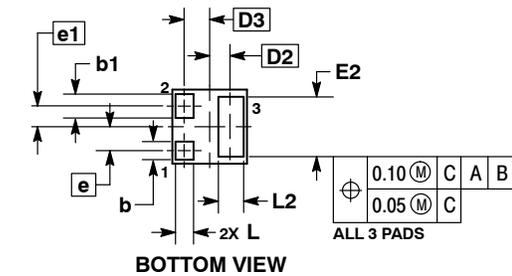
RECOMMENDED SOLDER FOOTPRINT*
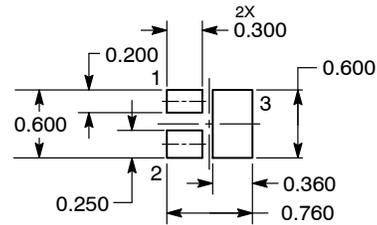
DIMENSIONS: MILLIMETERS

*For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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